Application/Control No. Applicant(s)/Patent Under Reexamination 10/720,088 TAKESUE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 **David Buttner** 1712 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0099120 07-2002 Takesue et al. 524/394 Α US-6,315,915 11-2001 Hebert et al. 216/67 В US-C US-D US-E US-F US-G US-US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code Name Classification MM-YYYY JP-2002-336378 JΡ 11-2002 Ichikawa N O Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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